

**Notice of References Cited**

Application/Control No.

10/618,682

Applicant(s)/Patent Under  
Reexamination  
LEE, ROBIN

Examiner

Madeleine AV Nguyen

Art Unit

2625

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,257,097 A	10-1993	Pineau et al.	358/500
*	B	US-5,617,528 A	04-1997	Stechmann et al.	715/517
*	C	US-5,754,184 A	05-1998	Ring et al.	345/604
*	D	US-2003/0174357 A1	09-2003	Lester et al.	358/1.15
*	E	US-6,947,158 B1	09-2005	Kitamura et al.	358/1.15
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.